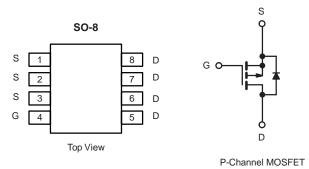


APM4305KC-TRL-VB Datasheet P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^d	Q _g (Typ.)			
- 30	0.011 at V _{GS} = - 10 V	- 11.6	22 nC			
- 30	0.012 at V _{GS} = - 4.5 V	- 10	22 110			



FEATURES

- Halogen-free According to IEC 61249-2-21 Available
- Trench Power MOSFET
- 100 % Rg Tested
- 100 % UIS Tested

APPLICATIONS

- Load Switches
- Notebook PCs
- Desktop PCs



COMPLIANT HALOGEN

FREE vailable

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	- 30	V		
Gate-Source Voltage	V _{GS}	± 20			
	T _C = 25 °C		- 11.6		
Continuous Drain Current ($T_1 = 150 \text{ °C}$)	T _C = 70 °C		- 10.5		
$Continuous Drain Current (1) = 150^{\circ} C)$	T _A = 25 °C	I _D	- 8.7 ^{a, b}		
	T _A = 70 °C		- 7.7 ^{a, b}	^	
Pulsed Drain Current	I _{DM}	- 40	— A		
Ocational Daris Dista Ocament	T _C = 25 °C	L.	- 4.6		
Continuous Source-Drain Diode Current	T _A = 25 °C	Is	2.0 ^{a, b}		
Avalanche Current	L = 0.1 mH	I _{AS}	- 20		
Single-Pulse Avalanche Energy	L = 0.1 mh	E _{AS}	20	mJ	
	T _C = 25 °C		5.6		
Maximum Dowar Dissinction	T _C = 70 °C	P _D	3.6	w	
Maximum Power Dissipation	T _A = 25 °C	'D	2.5 ^{a, b}	vv	
	T _A = 70 °C		1.6 ^{a, b}		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R _{thJA}	39	50	°C/W	
Maximum Junction-to-Foot	Steady State	R _{thJF}	18	22	C/W	

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.

c. Maximum under Steady State conditions is 85 °C/W. d. Based on $T_C = 25$ °C.

SPECIFICATIONS $T_J = 25 \text{ °C}$, unless otherwise noted								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Static								
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = -250 \mu A$	- 30			V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 31		mV/°C		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	iD = - 200 μA		5.5		mv/°C		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 1.0		- 3.0	V		
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 25 V$			± 100	nA		
Zoro Coto Voltago Droin Current	I _{DSS}	$V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			- 1			
Zero Gate Voltage Drain Current		V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 55 °C			- 5	μA		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge$ - 10 V, V_{GS} = - 10 V	- 30			А		
Droin Source On State Desistance	R _{DS(on)}	V _{GS} = - 10 V, I _D = - 10 A		0.011		Ω		
Drain-Source On-State Resistance ^a		$V_{GS} = -4.5 V, I_{D} = -7 A$		0.012				
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 10 A		23		S		
Dynamic ^b								
Input Capacitance	C _{iss}			1960				
Output Capacitance	C _{oss}	$V_{DS} = -15 V$, $V_{GS} = 0 V$, f = 1 MHz		380		pF		
Reverse Transfer Capacitance	C _{rss}			325				
Total Gate Charge	Qg	$V_{DS} = -15 \text{ V}, \text{ V}_{GS} = -10 \text{ V}, \text{ I}_{D} = -10 \text{ A}$		43	65	nC		
Iotal Gate Gharge	•			22	33			
Gate-Source Charge	90	V_{DS} = - 15 V, V_{GS} = - 4.5 V, I_{D} = - 10 A		6				
Gate-Drain Charge	Q _{gd}			11				
Gate Resistance	R _g	f = 1 MHz	0.3	1.3	2.5	Ω		
Turn-On Delay Time	t _{d(on)}			11	22			
Rise Time	t _r	V_{DD} = - 15 V, R_L = 3 Ω		13	25			
Turn-Off DelayTime	t _{d(off)}	$I_D\cong$ - 5 A, V_{GEN} = - 10 V, R_g = 1 Ω		32	50			
Fall Time	t _f			9	18	ns		
Turn-On Delay Time	t _{d(on)}			44	70	115		
Rise Time	t _r	V_{DD} = - 15 V, R_L = 3 Ω		100	160			
Turn-Off DelayTime	t _{d(off)}	$\rm I_D \cong$ - 5 A, $\rm V_{GEN}$ = - 4.5 V, $\rm R_g$ = 1 Ω		28	50			
Fall Time	t _f	t _f		15	30			
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			- 4.6	А		
Pulse Diode Forward Current	I _{SM}				- 50	~		
Body Diode Voltage	V _{SD}	$I_{S} = -2 \text{ A}, V_{GS} = 0 \text{ V}$		- 0.75	- 1.2	V		
Body Diode Reverse Recovery Time	t _{rr}			28	45	ns		
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 2 A, dl/dt = 100 A/µs, T _{.I} = 25 °C		20	40	nC		
Reverse Recovery Fall Time	t _a	$T_{\rm F} = 2.0, 4.00 = 100.0000, 10 = 20.000$		13		ns		
Reverse Recovery Rise Time	t _b			15				

Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

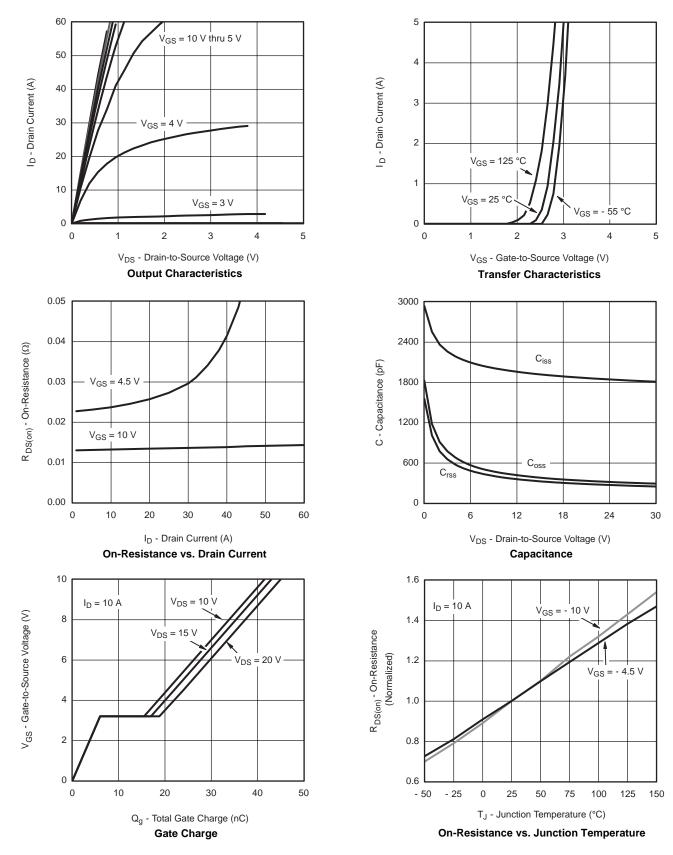
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Bsemi VBsemi.com



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



服务热线:400-655-8788



 $T_J = 125 \ ^\circ C$

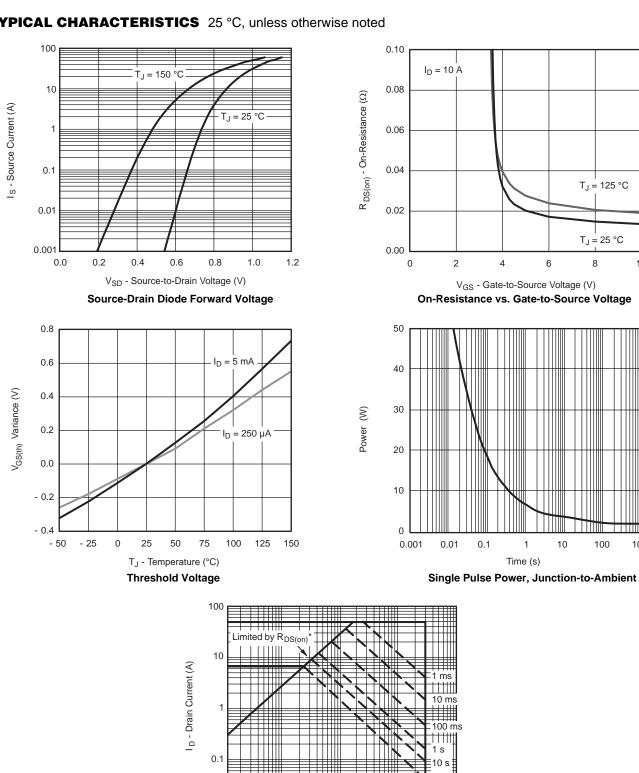
T_J = 25 °C

100

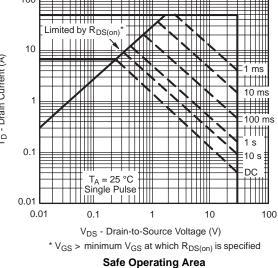
1000

10

8

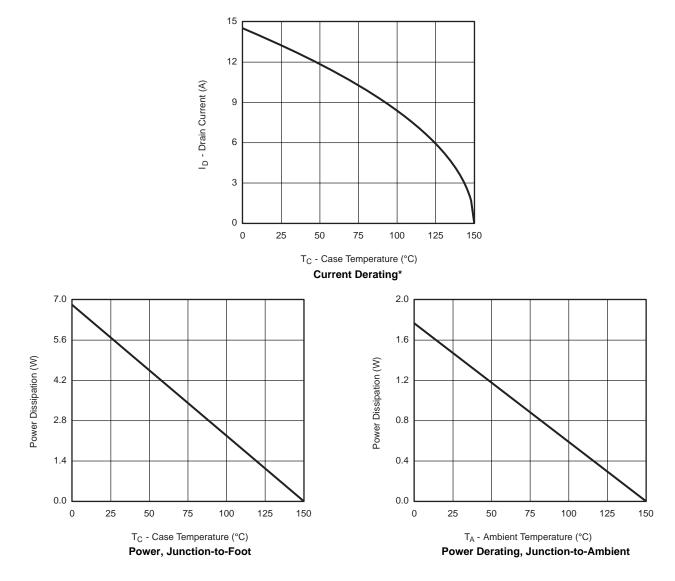


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





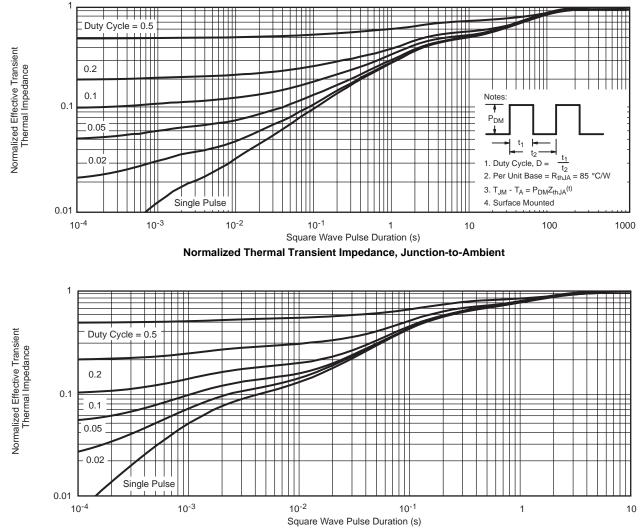
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



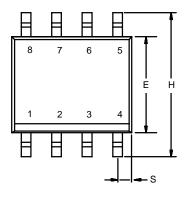
Normalized Thermal Transient Impedance, Junction-to-Foot

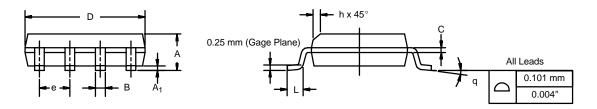
APM4305KC-TRL-VB



SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012

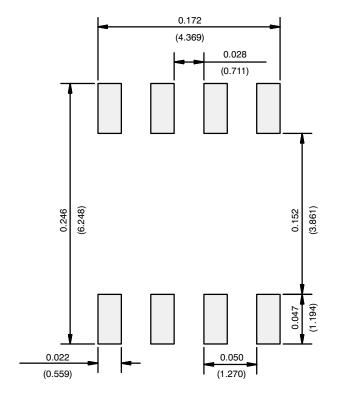




	MILLIMETERS			HES	
DIM	Min	Мах	Min	Max	
A	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498					



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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